

ASTP Board Calibration Certificate

2022-01-26 **VMP500RT SN230** P049R02 ASTP-LP SN153 National Taiwan Univ.

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1 Document Summary

This document contains the calibration parameters for the electronics on the P049R02 board, which controls the conditioning and sampling of the accelerometer, shear, thermistor and pressure (i.e. ASTP) signals. The ASTP board is present in your instrument (SN 230) and is common to many instruments built by Rockland Scientific. The ASTP board is designed specifically to have low electronic noise to enable the precise measurement of oceanic microstructure turbulence signals.

The calibration parameters that are summarized in this document need to be included in the setup.cfg file so that the data can be converted from raw counts to physical units. A summary of the necessary coefficients is provided in Section 2. These values are specific to instrument SN 230 and were entered into the setup.cfg file before it was shipped from Rockland Scientific's production facility, but it is important to verify that the values are correct prior to any deployment. Note: The calibration parameters for the sensors (e.g. shear probes, thermistors, CT sensor, etc.) are either provided in separate documents, or to be determined post-deployment via an *in situ* calibration¹.

The procedures and data used to generate the calibration parameters are outlined in the subsequent sections of the document. In particular:

- Section 3 gives the estimated power draw of the ASTP board.
- Section 4 outlines the calibration of the pressure transducer and the computed regression equation.
- Section 5 outlines the response of the thermistor channels to changes in input resistance.
- Section 6 outlines the frequency response of all the ASTP channels. The transfer functions are presented and the differentiator gains are summarized.
- Section 7 shows the electronic noise spectra from all the ASTP channels. Figure 12 should be used as a baseline to compare bench test data to.

If you have any questions regarding the ASTP calibration report, or your instrument in general, please contact support@rocklandscientific.com.

¹Note: The FP07 thermistor(s) are typically uncalibrated. We recommend performing a post-deployment *in situ* calibration, which is outlined in Technical Note 039.

2 Parameters for setup.cfg file

The following parameters should be included as the "instrument dependent" parameters in your setup.cfg file. For "sensor dependent" parameters (e.g. shear probe sensitivities), please refer to the appropriate calibration report, or determine them using an *in situ* calibration.

Thermistors:

	T1	T2
adc_fs	4.096	4.096
adc_Bits	16	16
a	-10.6	-11.8
b	0.99855	0.99885
G	6.0	6.0
E_B	0.68194	0.68210

Thermistors (with pre-emphasis):

	$T1_dT1$	$T2_dT2$
diff_gain	0.915	0.918

Shear Probes:

	sh1	sh2
adc_fs	4.096	4.096
adc_Bits	16	16
diff_gain	0.955	0.951

Pressure Sensor:

	P
$coef0^2$	-3.63
coef1	0.102153
coef2	-2.0092e-08

Pressure Sensor (with pre-emphasis):

	P_dP
diff_gain	20.05

²Note: The value of coef0 in the setup.cfg file on your instrument was adjusted to obtain a zero pressure reading at Rockland Scientific. Therefore, it will be slightly different than that determined from the regression (Section 4). The value of coef0 may need to be further adjusted for your deployment site. See the blog post on Rockland Scientific's website for details.

4 POWER DRAW

3 Power Draw

The measured voltage and current draw of the ASTP board is given in the following table:

Voltage [V]	Current [mA]	Limit [mA]
5.05	85	90

The corresponding power consumption is therefore: P = IV = 0.429 W

Note: This is only the analog power consumption of the ASTP board and the instrument itself will draw significantly more power. Consult your instrument manual.

4 Pressure Transducer Calibration

The pressure transducer was calibrated at Rockland Scientific using a dead weight tester. The details of the sensor and its calibration are as follows:

Date: 2022-01-27

Model: PA11/200BAR/80059

SN: 1014214

Circuit Board: P049R02 ASTP-LP SN153 Operator: Dave Cronkrite

Data were collected on both the pre-emphasized³ pressure channel (ch11) and the pressure channel (ch10) for applied pressures increasing from 200 psi to 1400 psi and then decreasing back to 200 psi, in 200 psi increments. The data are supplied in Table 1. A second order regression was used to determine the coefficients (Figure 1) that convert the measured counts into physical units. The equation is provided below. The Keller Calibration sheet is also provided for your reference (Figure 2).

Regression equation: $P = -3.6255 + 0.10215 \cdot N_{10} + -2.0092 \text{e-}08 \cdot N_{10}^2 \text{ [dBar]}$

Note: To zero your pressure sensor, the first coefficient can be adjusted. This was done in the **setup.cfg** file to account for the height difference of the pressure source and the pressure transducer. It may need to be adjusted specifically for your deployment site.

³For information on the pre-emphasis technique see Technical Note 003 available from the downloads section of Rockland Scientific's website

 Table 1: Pressure Calibration Data

P_dP [ch 11] P [ch 10] Pressure [PSI 1388 1388 200 2738 2737 400 4088 4088 600 5440 5440 800 6792 6793 1000 8145 8149 1200 9501 9503 1400 10853 10858 1600 12213 12214 1800 13571 13570 2000 14929 14929 2200
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16283 16287 2400
17646 17646 2600
19007 19005 2800
20368 20364 3000
20369 20364 3000
19008 19005 2800
17648 17646 2600
16286 16287 2400
14927 14929 2200
13571 13572 2000
12216 12213 1800
10856 10858 1600
9501 9502 1400
8148 8148 1200
6793 6793 1000
5440 5440 800
4088 4088 600
2738 2736 400
1386

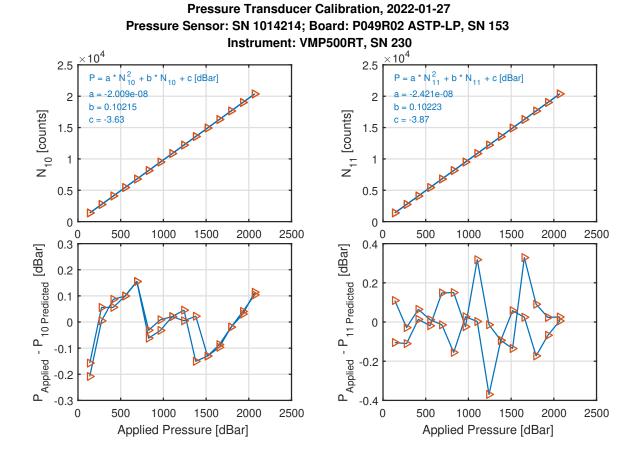


Figure 1: Pressure calibration data and second order regressions (top row) and the regression errors (bottom row).



Figure 2: Keller Calibration Sheet

5 Thermistor Resistance Response

The purpose of this section is to test the accuracy, linearity and precision of the thermistor circuit. It also provides the relationship between thermistor resistance and the output of the thermistor circuit. This relationship, and the calibration of the thermistor itself⁴, are used to convert the data into physical units. The details of the thermistor circuit are as follows:

Date: 2022-01-26

Circuit Board: P049R02 ASTP-LP SN153

Operator: Dave Cronkrite

Reference Voltage V_{ref} [V] 2.0468 T1 excitation voltage E_{B1} [V] 0.68194 T2 excitation voltage E_{B2} [V] 0.6821 Designed excitation voltage E_{B} [V] 0.68227 Circuit front end gain G 6

The table below shows the measured response of the thermistor output channels, in units of counts, to a change in resistance of a probe. The thermistor probe was simulated with a Vishay decade resistance box of 0.01% accuracy. Low resistance represents high temperature, while high resistance corresponds to low temperatures of an actual thermistor. The nominal resistance of FP07 thermistors should be 3000Ω at 17° C, which is the balance point of the thermistor circuit on the ASTP board. Resistances of 5000Ω and 2000Ω correspond approximately to 2 and 25° C, respectively.

T1 [ch4]	T1_dT1[ch5]	T2[ch6]	T2_dT2[ch7]	$RT[\Omega]$
10884.9	10901.6	10889.7	10909.2	1500.0
6526.6	6540.5	6528.8	6545.1	2000.0
2960.7	2972.9	2961.1	2974.4	2500.0
-10.6	-0.9	-12.0	-0.6	3000.0
-2524.9	-2516.5	-2527.6	-2518.0	3500.0
-4680.2	-4673.7	-4684.0	-4675.9	4000.0
-6547.8	-6541.4	-6552.6	-6545.8	4500.0
-8182.0	-8177.0	-8187.4	-8181.6	5000.0
-10905.4	-10902.0	-10912.3	-10909.1	6000.0

 $^{^4}$ The resistance-temperature relationship of a thermistor can be established by calibration in a laboratory bath, but it can also be established in situ from a simultaneous measure of the environmental temperature by an independent thermometer attached to the instrument. Refer to Technical Note 039 for information on performing this $in\ situ$ calibration

The expected output, in counts, from the thermistor circuit (x) is:

$$x = \frac{2^B}{V_{FS}} \frac{GE_B}{2} \frac{R_0 - R_T}{R_0 + R_T} \tag{1}$$

where R_T is the applied resistance and $R_0 = 3000 \,\Omega$ is the nominal resistance of an FP07 thermistor. The other parameters are functions of the circuit where G is the gain, E_B is the bridge excitation voltage (one-third of $V_{ref} = 2.048 \,\mathrm{V}$), and B = 16 and $V_{FS} = 4.096 \,\mathrm{V}$ are the number of bits and full-scale range of the AD-Converter, respectively⁵.

The measured outputs $(N_4 \text{ and } N_6)$ from the thermistor channels are compared against the expected outputs (x) in the top panels of Figure 3 for thermistor 1 (ch4), and in Figure 4 for thermistor 2 (ch6). The measured outputs are regressed against the expected outputs using

$$N = a + bx \tag{2}$$

where N is the output in counts and a and b are the regression coefficients. Since N is expected to be close to x, the offset, a, should be small and the slope, b, should be close to unity.

The errors in the regression fit as a function of thermistor resistance ratio, R_T/R_0 , are shown in the middle and lower subpanels of Figure 3 and Figure 4. The middle panel shows the difference, in counts, between the measured output and the output predicted by the linear regression, i.e. eq. (2). The bottom panel shows the error in R_T/R_0 itself. By combining eqs. (1) and (2), it can be shown that

$$\frac{R_T}{R_0} = \frac{1 - Z}{1 + Z},\tag{3}$$

where

$$Z = \left(\frac{N-a}{b}\right) \frac{V_{FS}}{2^B} \frac{2}{GE_B}.$$
 (4)

⁵See Technical Note 005 available from the downloads section of Rockland Scientific's website.

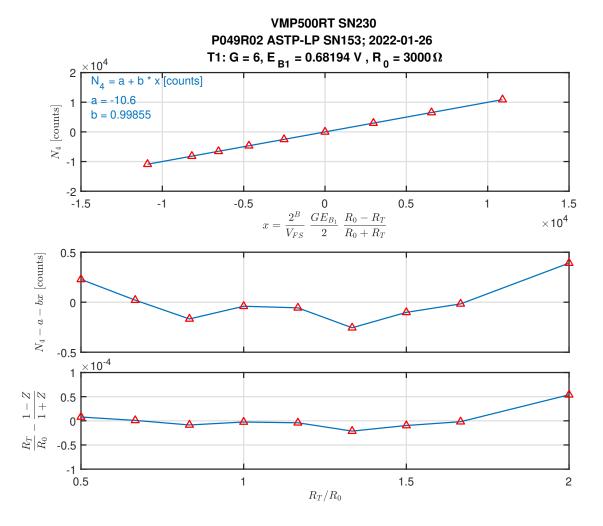


Figure 3: (Top panel) Linear regression of the actual output from ch4 (N_4) against the expected output, x, described by (1). The linear least-squares fit gives the offset, a, and the slope, b. (Middle panel) The difference, in counts, between the measured output and the output estimated from the linear regression as a function of the thermistor resistance ratio, R_T/R_0 . (Bottom panel) The difference between the measured thermistor resistance ratio, R_T/R_0 and that predicted by the inverse linear regression, i.e. eq. 3, where Z is defined in eq. 4.

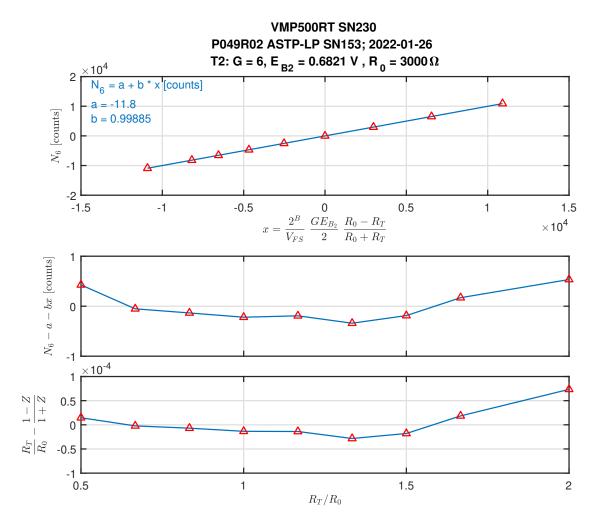


Figure 4: (Top panel) Linear regression of the actual output from ch6 (N_6) against the expected output, x, described by (1). The linear least-squares fit gives the offset, a, and the slope, b. (Middle panel) The difference, in counts, between the measured output and the output estimated from the linear regression as a function of the thermistor resistance ratio, R_T/R_0 . (Bottom panel) The difference between the measured thermistor resistance ratio, R_T/R_0 and that predicted by the inverse linear regression, i.e. eq. 3, where Z is defined in eq. 4.

6 Frequency Response of ASTP Board

The frequency response of the the thermistor, shear probe, pressure and piezo-accelerometer circuits was calibrated by applying known input signals and recording the sampled output from these channels (see Figure 5).

To generate the input signal, we use a custom built signal generator that produces synthetic pink noise which has a spectrum that decreases inversely with frequency. Precision attenuators in the ODAS Calibrator (P034R03) reduce the signal amplitudes and band limit the signals to make them suitable for direct input in to the ASTP signal conditioning board. The band limited signal without attenuation is used as reference and sent to channel 15.

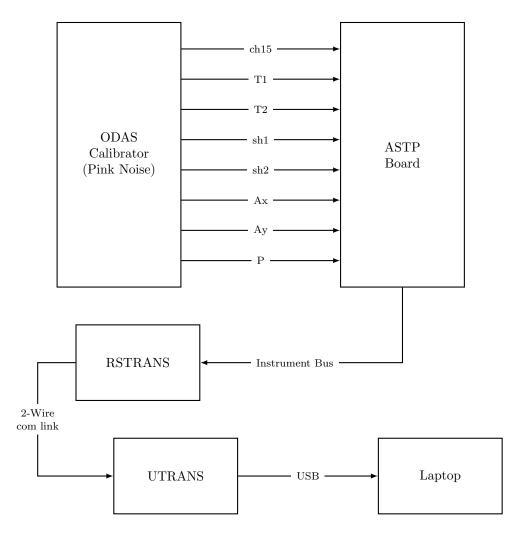


Figure 5: Schematic illustration of setup for frequency response testing of the thermistor, shear probe, accelerometer and pressure channels of a ASTP board.

For each channel, spectra are plotted of the input and output signals used for the frequency response calibration (Figure 6 for pressure, Figure 7 for thermistor, shear and piezo-accelerometer). The frequency response relative to that of an ideal differentiator are shown separately in Figures 8-11.

The differentiator gains of the microstructure signals are derived from these calibrations and are required to deconvolve these signals and to convert them into physical units.

Channel	Calibrated gain relative to an ideal differentiator
P_dP	20.05
sh1	0.955
sh2	0.951
$T1_dT1$	0.915
$T2_dT2$	0.918
Ax	0.957
Ay	0.962

Table 2: Differentiator gain calibration results.

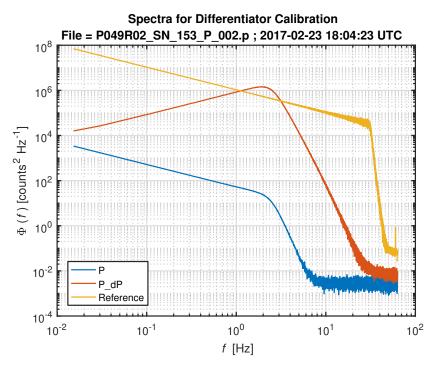


Figure 6: Spectra of signals used for the frequency response calibration of the pressure channels. The raw pressure output (ch10) is blue while the pre-emphasized output (ch11) is red. The effectiveness of the 2.5 Hz 8th order Butterworth low-pass filters on the pressure signals is evident by the spectral roll-off at 2.5 Hz.

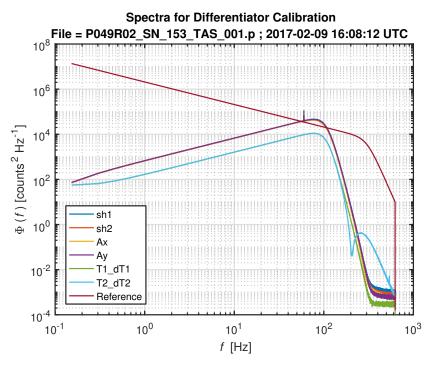


Figure 7: Spectra of signals used for the frequency response calibration of the shear probe, accelerometer and thermistor channels. Note: the shear and accelerometer channels should be overlapping because the circuitry is the same.

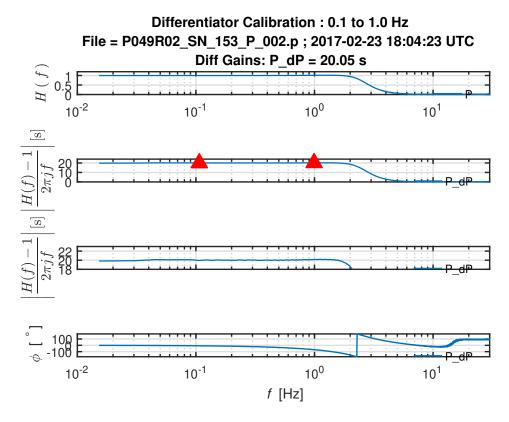


Figure 8: Transfer functions of pressure circuits. Upper panel: Pressure channel (P, ch10) with 2.5 Hz anti-aliasing filter. Second panel: Gain of pre-emphasized pressure channel $(P_dP, \text{ch11})$ relative to pressure (P, ch10). This channel is also low-pass filtered at 2.5 Hz. The gain of the differentiator that creates the pre-emphasized pressure signal is indicated in the figure and is the average gain over the frequency limits indicated by the red triangles. The output of the pre-emphasized pressure channel is $P + G_D \times \partial P/\partial t$ where P is the voltage from the pressure channel (ch10). Third panel: Same as second panel but with zoom-in view. Lower panel: The phase transfer function of the pre-emphasized pressure channel.

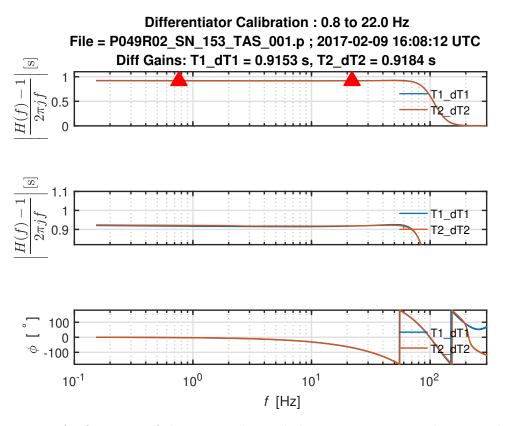


Figure 9: Transfer functions of the pre-emphasized thermistor circuits, relative to that of an ideal differentiator. The gains of the differentiators are indicated in the title and represent the mean gain between the frequency limits indicated by the red triangles. Upper panel: Gain with respect to frequency. Middle panel: Same but with zoom-in view. Lower panel: phase with respect to frequency.

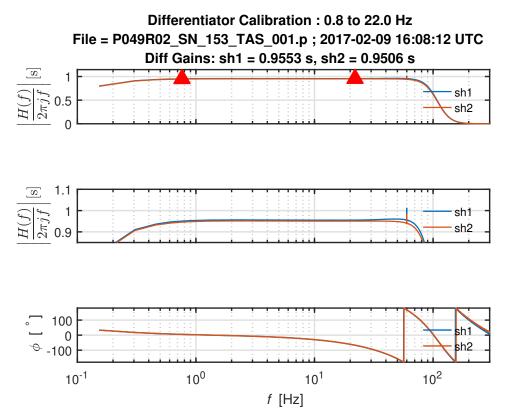


Figure 10: Transfer functions of the shear probe circuits, relative to that of an ideal differentiator. The charge-transfer amplifier responds only to AC signals and has its half-power response at 0.1 Hz. The gains of the differentiators are indicated in the title and represent the mean gain between the frequency limits indicated by the red triangles. Upper panel: Gain with respect to frequency. Middle panel: Same but with zoom-in view. Lower panel: phase with respect to frequency.

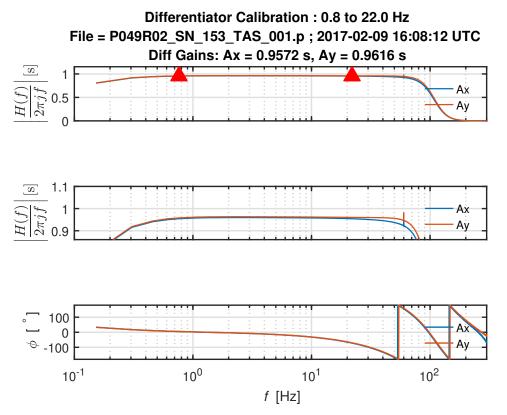


Figure 11: Transfer functions of the piezo-accelerometer circuits, relative to that of an ideal differentiator. The charge-transfer amplifier responds only to AC signals and has its half-power response at 0.1 Hz. The gains of the differentiators are indicated in the title and represent the mean gain between the frequency limits indicated by the red triangles. Upper panel: Gain with respect to frequency. Middle panel: Same but with zoom-in view. Lower panel: phase with respect to frequency.

7 ASTP Output Noise Spectra

Noise measurements were taken by using test thermistor probes of $3000\,\Omega$ resistance and opencircuit test shear probes. The piezo-accelerometers were disconnected from the inputs to the board. The pressure transducer was disconnected from the board, and the differential input to the ASTP board was shorted to the reference voltage.

All measurements are given in terms of counts from the 16-bit analog-to-digital converter, on the ASTP board. One count equals $62.5\,\mu\text{V}$. All spectra have the property that the integral from zero to the Nyquist frequency equals the signal variance.

Models for the thermistor and shear channel noise are shown by the thin black lines and acceptable ranges, i.e. within a factor of two of the model, are represented by the grey bands⁶.

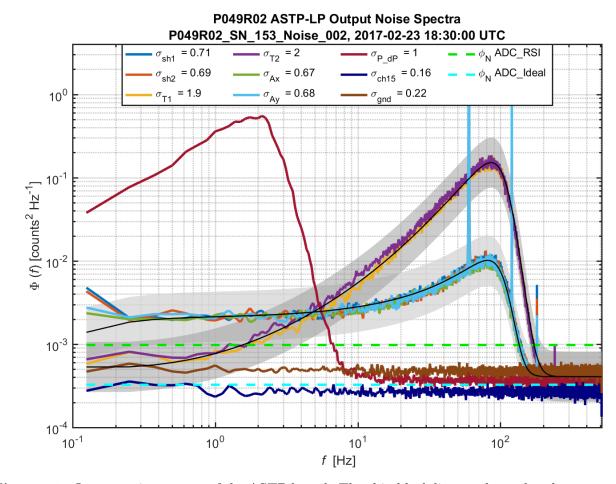


Figure 12: Output noise spectra of the ASTP board. The thin black lines and grey bands correspond to the modelled noise and acceptable noise ranges, respectively. GND (ch0) is a hard-wired virtual ground and ch15 is the reference channel. The two horizontal dashed lines show the quantization (or sampling) noise of an ideal converter (cyan) and the typical performance of the RSI converters (green), when a sample rate of $512 \, \text{Hz}$ is used. The standard deviations (σ) are for the 0–100 Hz band.

— End of Report —

⁶The details of these noise models are found in Technical Note 040 (thermistor) and 042 (shear), available from the downloads section of Rockland Scientific's website.